## Notice of References Cited

'	plication/Control No. /944,832	Reexamination	Applicant(s)/Patent Under Reexamination JACOBS ET AL.		
Ex	aminer	Art Unit			
W	oo H. Choi	2186	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,370,620 B1	04-2002	Wu et al.	711/132
	В	US-2002/0026560	02-2002	JORDAN et al.	711/120
	С	US-6,266,742 B1	07-2001	Challenger et al.	711/133
	D	US-2002/0184368 A1	12-2002	Wang, Yunsen	709/226
	E	US-2002/0107935 A1	08-2002	Lowery et al.	709/216
	F	US-6,697,849 B1	02-2004	Carlson, Bjorn	709/219
	G	US-2003/0120752 A1	06-2003	Corcoran, Michael	709/219
	Н	US-6,317,778 B1	11-2001	Dias et al.	709/214
	ı	US-	"		
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q				·	
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.